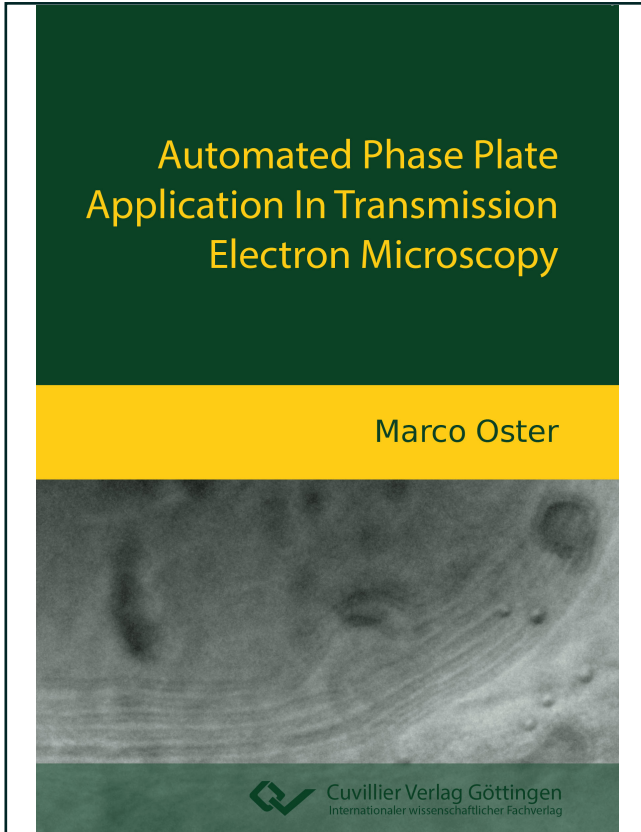




Marco Oster (Autor)

Automated Phase Plate Application In Transmission Electron Microscopy



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